

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/853,770	SHIGEMATSU ET AL.		
Examiner	Art Unit		
Ellen C. Tran	2134		

SEARCHED					
Class	Subclass	Date	Examiner		
713	186	6/4/2007	ECT		
726	9	6/4/2007	ECT		
726	20	6/4/2007	ECT		

INTERFERENCE SEARCHED				
Subclass	Date	Examine		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
,	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH	6/4/2007	ECT
ALL CLAIMS WERE REVIEWED FOR POSSIBLE 101 REJECTIONS	6/4/2007	ECT